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## AMENDMENTS TO THE CLAIMS

Please amend Claims 1, 4, 7, 9-13, 15 and 16.

Please cancel Claims 2, 3, 8, 14 and 17-19.

Please add Claims 21-37.

1. (Currently amended) A method of electrochemically filling cavities on a wafer surface to form a substantially planar conductive layer, comprising the steps of:

applying a first cathodic current to form a first conductive layer on the wafer surface, the first conductive layer wafer having a planar portion over a first cavity and a non-planar portion over a second cavity, wherein the first cavity is an unfilled cavity with has the smallest width and the second cavity has the next a larger width [[after]] than the smallest first cavity, and wherein the first and the second cavities are less than 10 micrometers in width;

treating <u>a</u> surface of the first conductive layer by applying a first <del>pulsed current</del> anodic current waveform; [[and]]

applying a second cathodic current to form a second conductive layer on the first conductive layer, the second conductive layer having a planar portion over both the first and second cavities; and

treating a surface of the second conductive layer by applying a second anodic current waveform,

wherein the second anodic current waveform has a longer duration than the first anodic current waveform.

- 2. (Canceled)
- 3. (Canceled)
- 4. (Currently amended) The method of claim 1, wherein the step of treating the surface of the first conductive layer prevents bump formation on the surface of the first conductive layer.
- 5. (Original) The method of claim 1, wherein the steps of applying first and second cathodic currents comprise applying DC voltage.
- 6. (Original) The method of claim 1, wherein the steps of applying first and second cathodic currents comprise applying AC voltage.

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7. (Currently amended) The method of claim [[11]] 1, further comprising the step of repeating the steps of treating and applying until all the cavities on the wafer surface are filled.

- 8. (Canceled)
- 9. (Currently amended) A method to electrochemically fill a plurality of cavities on a wafer surface comprising the steps:

applying a first cathodic current to fill a first cavity and partially fill a second cavity with a first conductive layer on the wafer surface, the first cavity having a smaller width than the second cavity wherein the first cavity and the second cavity each include a width less than 10 micrometers;

applying a <u>first anodic current waveform</u> pulsed current to treat the first conductive layer, the first anodic current waveform comprising at least one anodic current pulse; [[and]]

applying a second cathodic current to fill the second cavity with a second conductive layer to form a substantially planar conductive layer over the first cavity and the second cavity; and

applying a second anodic current waveform to treat the second conductive layer, the second anodic current waveform comprising at least one anodic current pulse,

wherein the second anodic current waveform has a longer duration than the first anodic current waveform.

- 10. (Currently amended) The method of claim 9, wherein the step of applying the <u>first</u> cathodic current includes <u>applying</u> a cathodic DC waveform.
- 11. (Currently amended) The method of claim 9, wherein the step of applying the <u>first</u> cathodic current includes <u>applying</u> a cathodic [[DC]] <u>AC</u> waveform.
- 12. (Currently amended) The method of claim 9, wherein the step of applying a pulsed current the first anodic current waveform includes a plurality of anodic pulsed current pulses.
- 13. (Currently amended) The method of claim 12, wherein the step of applying the plurality anodic pulsed current includes pulses the anodic current pulses are each [[of]] approximately 1 second in duration.
  - 14. (Canceled)

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15. (Currently amended) A method of electrochemically filling cavities on a wafer surface to form a substantially planar conductive layer, comprising:

<u>providing</u> a first <u>cavity being an unfilled</u> cavity with a smallest width and a second cavity having a [[next]] larger width <u>than the first cavity</u>, wherein the first and [[the]] second cavities are less than 10 micrometers in width, the method comprising:

applying a first cathodic current <u>waveform</u> to form a first conductive layer on the wafer surface, the first conductive layer having a planar portion over a first cavity and a non-planar portion over a second cavity, the first cavity being filled and the second cavity being unfilled;

treating the first conductive layer <u>by applying a first anodic current waveform;</u> [[and]]

applying a second cathodic current <u>waveform</u> to form a second conductive layer on the first conductive layer, the second conductive layer having a planar portion over [[both]] the first and second cavities <u>cavity</u>; and

treating the second conductive layer by applying a second anodic current waveform,

wherein the second cathodic current waveform has a longer duration than the first cathodic current waveform and the second anodic current waveform has a longer duration than the first anodic current waveform.

- 16. (Currently amended) The method of claim 15, wherein the step of applying the first cathodic current includes applying a cathodic rectangular waveform.
  - 17. (Canceled)
  - 18. (Canceled)
  - 19. (Canceled)
  - 20. (Original) The method of claim 15, wherein the planar conductive layer is copper.
- 21. (New) The method of claim 1, wherein the step of applying the first cathodic current comprises forming the first conductive layer including a planar portion over the first cavity and a non-planar portion over the second cavity.
- 22. (New) The method of claim 1, wherein the step of applying the second cathodic current comprises forming the second conductive layer including a planar portion over both the first and second cavities.

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23. (New) The method of claim 1, wherein the step of treating the surface of the second conductive layer prevents bump formation on the surface of the second conductive layer.

- 24. (New) The method of claim 1, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.
- 25. (New) The method of claim 1, wherein the second cathodic current is applied for a longer time than the first cathodic current.
- 26. (New) The method of claim 9, wherein applying the second cathodic current includes applying a cathodic DC waveform.
- 27. (New) The method of claim 9, wherein applying the second cathodic current includes applying a cathodic AC waveform.
- 28. (New) The method of claim 9, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.
- 29. (New) The method of claim 9, wherein the second cathodic current is applied for a longer time than the first cathodic current.
- 30. (New) The method of claim 9, wherein the second anodic current waveform includes a plurality of anodic current pulses.
- 31. (New) The method of claim 30, wherein the anodic current pulses are each approximately 1 second in duration.
- 32. (New) The method of claim 15, wherein the second cathodic current waveform is a cathodic rectangular waveform.
- 33. (New) The method of claim 15, wherein the first anodic current waveform includes a plurality of anodic current pulses of approximately 1 second in duration.
- 34. (New) The method of claim 15, wherein the second anodic current waveform includes a plurality of anodic current pulses of approximately 1 second in duration.
- 35. (New) The method of claim 15, wherein the second anodic current waveform includes a greater number of anodic current pulses than the first anodic current waveform.
- 36. (New) The method of claim 15, wherein applying the first cathodic current waveform comprises forming the first conductive layer including a planar portion over the first cavity and a non-planar portion over the second cavity.
- 37. (New) The method of claim 36, wherein the first cavity is filled and the second cavity is unfilled.